Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/073,129	SATO ET AL.	
Examiner	Art Unit	_
John I Tabana Ir	2122	

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Class	Subclass	Date	Examiner	
714	25,30,42 702,718 720,724- 740	6/17/2005	JJT	
365	201,63,51			
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Class	Subclass	Date	Examiner		
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
IEEE Search (see seach notes)	6/16/2005	JJT
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